

Search Notes

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Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under
Reexamination

POLIVKA ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
336	65, 83, 183, 192, 200, 220- 223	4/30/2005	TTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR